SHIGA7.032APC PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Hojo et al.

Appl. No. : 10/554,380

Filed : October 26, 2005

For : POSITIVE PHOTORESIST

COMPOSITION AND METHOD

FOR FORMING RESIST

PATTERN

Examiner : A. Eoff

Group Art Unit : 1753

AMENDMENT AND RESPONSE TO OFFICE ACTION

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In response to the Office Action mailed September 10, 2007, Applicants respectfully request the Examiner to enter the following amendments and consider the following remarks.

Amendments to the claims are reflected in the listing of claims which begins on page 2 of this paper.

Remarks begin on page 5 of this paper.